

# TRANSMITTAL FORM

(To be used for all correspondence after initial filing)

10/766,696
January 27, 2004
Bengt Ivarsson
740073.448C2

ENCLOSURES (check all that apply)				
Fee Transmittal Form Fee Attached Amendment/Response After Final Affidavits/declaration(s) Extension of Time Request Express Abandonment Request Information Disclosure Statement; Form PTO-1449 Cited References Certified Copy of Priority Document(s) Response to Missing Parts under 37 C.F.R. 1.52 or 1.53 Response to Missing Parts/Incomplete Application	Drawing(s) Request for Corrected Filing Receipt Licensing-related Papers Petition Petition to Convert to a Provisional Application Power of Attorney, Revocation, Change of Correspondence Address Declaration Statement under 37 CFR 3.73(b) Terminal Disclaimer Request for Refund	CD(s), Number of CD(s)  After Allowance Communication to Group Appeal Communication to Board of Appeals and Interferences Appeal Communication to Group (Appeal Notice, Brief, Reply Brief) Proprietary Information Status Letter Return Receipt Postcard Additional Enclosure(s) (please identify below):		
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Date April 29, 200	4			
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Signature  This collection of information is required by 37 CFR 1.	5. The information is required to obtain or retain a benefit	Date: April 29, 2004  by the public which is to file (and by the USPTO to		

process) an application. Confidentiality is governed by 35 U.S.C. 122/and 37 FFR 1.14. This collection is estimated to take 12 minutes to complete, including gathering, preparing, and submitting the completed application form to the USP/TO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this barden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria VA 22313/450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO:

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**PATENT** 

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Jason Añover

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

**Applicant** 

Bengt Ivarsson

Application No.

10/766,696

Filed -

January 27, 2004

For

ANALYTICAL METHOD AND APPARATUS

Docket No.

740073.448C2

Date

April 29, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

#### INFORMATION DISCLOSURE STATEMENT

#### Commissioner for Patents:

In accordance with 37 C.F.R. §§ 1.56 and 1.97 through 1.98, applicant wishes to make known to the U.S. Patent and Trademark Office the references set forth on the attached Form PTO-1449. This application is a continuation and relies, under 35 U.S.C. § 120, on the earlier filing date of prior Application No. 10/244,819, filed September 16, 2002 which is a continuation prior Application No. 09/368,461, filed August 4, 1999. The references listed on the attached Form PTO-1449 were submitted to and/or cited by the Patent and Trademark Office in these prior applications and, therefore, are not required to be provided in this application. If the Examiner wishes, copies will be provided upon request. As to any reference supplied, applicant does not admit that it is "prior art" under 35 U.S.C. §§ 102 or 103, and specifically reserves the right to traverse or antedate any such reference, as by a showing under 37 C.F.R. § 1.131 or other method. Although the aforesaid references are made known to the Patent and

Trademark Office in compliance with applicant's duty to disclose all information he is aware of which is believed relevant to the examination of the above-identified application, applicant believes that his invention is patentable.

Please acknowledge receipt of this Information Disclosure Statement and kindly make the cited references of record in the above-identified application.

Applicant believes this Information Disclosure Statement has been timely filed, however, the Director is authorized to charge any fee due by way of this Information Disclosure Statement to our Deposit Account No. 19-1090.

Respectfully submitted,
Seed Intellectual Property Law Group PLLC

Karl R. Hermanns

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Enclosures:

ij

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FORM PTO-144 (REV.7-80) DISCLOSURE STATEMENT (Use several sheets if necessary)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. 740073.448C2

APPLICATION NO. 10/766,696

APPLICANT

Bengt Ivarsson

FILING DATE January 27, 2004 GROUP ART UNIT

### **U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6,493,097	12/10/02	Ivarsson	356	630	
[ ]	AB						
	AC						
	AD	, , , , , , , , , , , , , , , , , , , ,		4			
	AE						

### FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DOCUMENT NUMBER DATE COUNTRY	TRANSLATIO	
			ONDER DATE	COONIKI	YES NO
a	AF	286 195 A2	10/12/88	ЕРО	
•	AG	WO 90/05295	05/17/90	PCT	
\$	АН	WO 93/14392	07/22/93	PCT	
	AI				

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AJ	Berger et al., "Resolution in surface plasmon microscopy," <i>Review of Scientific Instruments</i> 65(9): 2829-2836, 1994.
AK	Hayashi et al., "Experimental instrument for observing angle- and frequency-scanned attenuated total reflection spectra," <i>Review of Scientific Instruments</i> 67(9): 3039-3043, 1996.
AL	Karlsen et al., Simultaneous determination of refractive index and absorbance spectra of chemical samples using surface plasmon resonance," <i>Sensors and Actuators B</i> (Part II): 747-749, 1995.
АМ	Knoll, "Optical Characterization of Organic Thin Films and Interfaces with Evanescent Waves," MRS Bulletin 16: 23-39, 1991.
AN	Lenferink et al., "An improved optical method for surface plasmon resonance experiments," Sensors and Actuators B3(4): 261-265, 1991.

**DATE CONSIDERED** 

\* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).